Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/903,242	CUBLEY ET AL.	
Examiner	Art Unit	
Shih Chao Chan	2821	

	SEAR	CHED	
Class	Subclass	Date	Examiner
343	700MS, 702, 846	1/4/2006	CHEN
			<u></u>

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
EAST (See attached printout).	1/4/2006	CHEN
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